

1200V, 170A, N-channel SiC power MOSFET

General Description:

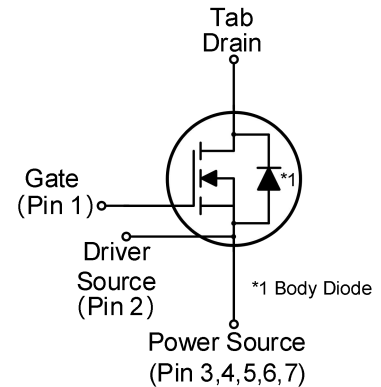
NCES120P013D7 is a SiC MOSFET that contributes to miniaturization and low power consumption of applications. This product achieves industry-leading low on-resistance without sacrificing short-circuit withstand time. This is a TO263-7L package type with a driver source terminal that can maximize the high-speed switching performance that is a feature of SiC MOSFETs.

Features

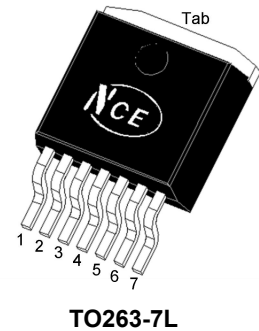
- Low on-resistance
- Fast switching speed
- Fast reverse recovery
- Easy to parallel
- Simple to drive
- Pb-free lead plating ; RoHS compliant

Application

- Solar inverters
- DC/DC converters
- Switch mode power supplies
- Induction heating
- Motor drives



Schematic diagram



Package Marking and Ordering Information

Device	Device Package	Device Marking
NCES120P013D7	TO263-7L	NCES120P013D7

Absolute Maximum Ratings (T_c=25°C unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	V _{DS}	1200	V
Gate-Source Voltage,max static voltage	V _{GS}	-10 to +24	V
Gate-Source Voltage,max transient voltage (Note 1)	V _{GS}	-11 to +26	V
Drain Current-Continuous (Note 2)	I _D	170	A
Drain Current-Continuous(T _C =100°C)	I _D (100°C)	120	A
Pulsed Drain Current (Note 3)	I _{DM}	425	A
Maximum Power Dissipation	P _D	T _{vj} = 25°C	750
		T _{vj} = 100°C	375
Recommended turn-on gate - source drive voltage	V _{GS_on}	+15 to +18	V
Recommended turn-off gate - source drive voltage	V _{GS_off}	-4 to 0	V
Virtual junction temperature	T _{vj}	175	°C
Operating Junction and Storage Temperature Range	T _J , T _{STG}	-55 To 175	°C

Thermal Characteristic

Symbol	Parameter	Value	Units
R _{θJC}	Thermal Resistance, Junction to case	0.2	°C/W

Electrical Characteristics (T_c=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit	
Off Characteristics							
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =100μA	1200			V	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =1200V, V _{GS} =0V	T _{vj} = 25°C	1	80	μA	
			T _{vj} = 175°C	2			
Gate-Body Leakage Current	I _{GSS}	V _{GS} =-10V / +24V, V _{DS} =0V			±100	nA	
On Characteristics (Note 4)							
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =20mA	T _{vj} = 25°C	1.9	3.0	4.8	V
			T _{vj} = 175°C		2.1		
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =18V, I _D =60A	T _{vj} = 25°C	13	17	mΩ	
			T _{vj} = 175°C	19			
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =15V, I _D =60A	T _{vj} = 25°C	16	21	mΩ	
			T _{vj} = 175°C	24			
Gate input resistance	R _G	f=1MHZ, open drain		0.5		Ω	
Forward Transconductance	g _{FS}	V _{DS} =20V, I _D =60A		14		S	
Dynamic Characteristics (Note 5)							
Input Capacitance	C _{ISS}	V _{DS} =800V, V _{GS} =0V, f=1MHZ		6300		pF	
Output Capacitance	C _{OSS}			270		pF	
Reverse Transfer Capacitance	C _{RSS}			6		pF	
C _{OSS} stored energy	E _{OSS}			105		μJ	
Output charge	Q _{OSS}	Calculated by C _{OSS} (f)V _{DS} @1MHZ		395		nC	
Effective output capacitance, energy related	C _{O(er)}	V _{DS} =0-800V, V _{GS} =0V		329		pF	
Effective output capacitance, time related	C _{O(tr)}	I _C =constant, V _{DS} =0-800V, V _{GS} =0V		494		pF	
Switching Characteristics (Note 5)							
Turn-on Delay Time	t _{d(on)}	V _{DD} =800V, I _D =60A, V _{GS} =+18V / -3V, R _G =2.7Ω, L=200μH		20.2		ns	
Turn-on Rise Time	t _r			33.5		ns	
Turn-Off Delay Time	t _{d(off)}			50.3		ns	
Turn-Off Fall Time	t _f			15		ns	
Turn-on energy	E _{on}	V _{DD} =800V, I _D =60A, V _{GS} =+18V / -3V, R _G =2.7Ω, L=200μH	T _{vj} = 25°C	888		μJ	
			T _{vj} = 175°C	1128		μJ	
Turn-off energy	E _{off}	R _G =2.7Ω, L=200μH	T _{vj} = 25°C	343		μJ	
			T _{vj} = 175°C	483		μJ	
Total Gate Charge	Q _g	V _{DS} =800V, I _D =60A, V _{GS} =-3/18V		236		nC	
Gate-Source Charge	Q _{gs}			73		nC	
Gate-Drain Charge	Q _{gd}			74		nC	

Electrical Characteristics (T_C=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
Drain-Source Diode Characteristics						
Diode Forward Voltage (Note 4)	V _{SD}	V _{GS} =0V, I _D =60A	T _{vj} = 25°C		3.5	V
			T _{vj} = 175°C		3.2	
Reverse Recovery Time	t _{rr}	T _J = 25°C, I _F =60A, V _R =800V, di/dt = 4160A/μs (Note3)		20.2		ns
Reverse Recovery Charge	Q _{rr}			566		nC
Peak reverse recovery current	I _{rrm}			49.5		A

Notes:

1. t_p < 500ns, D < 0.01
2. Repetitive Rating: Pulse width limited by maximum junction temperature.
3. PW ≤ 10μs, Duty cycle ≤ 1%
4. Pulse Test: Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.
5. Guaranteed by design, not subject to production

Test Circuit

Fig.1-1 Gate Charge Measurement Circuit

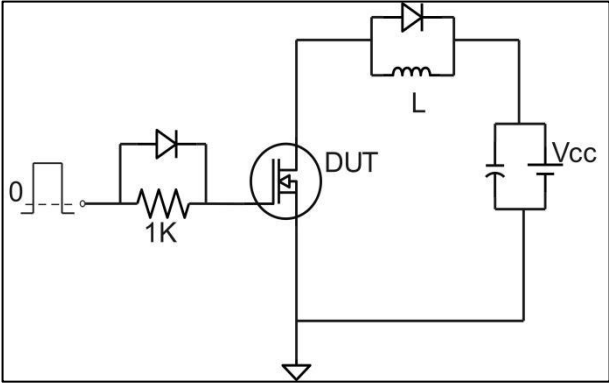


Fig.1-2 Gate Charge Waveform

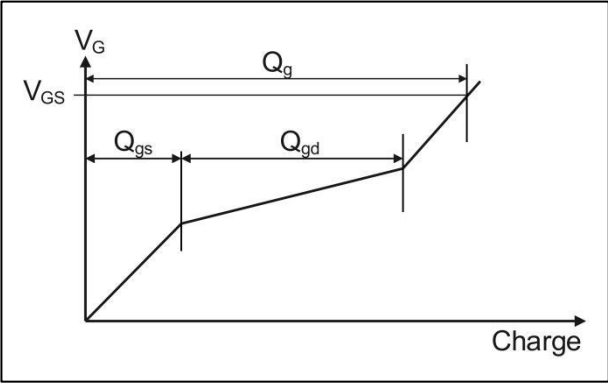


Fig.2-1 Switching Characteristics Measurement Circuit

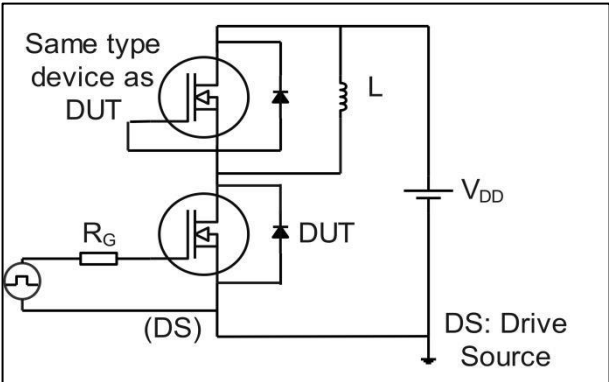
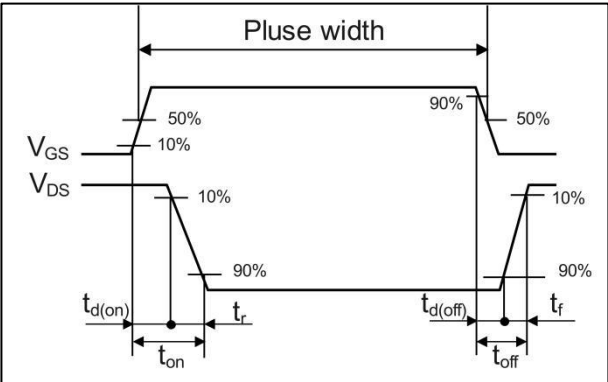


Fig.2-2 Waveforms for Switching Time



Typical Electrical and Thermal Characteristics

Fig.1 Power Dissipation Derating Curve

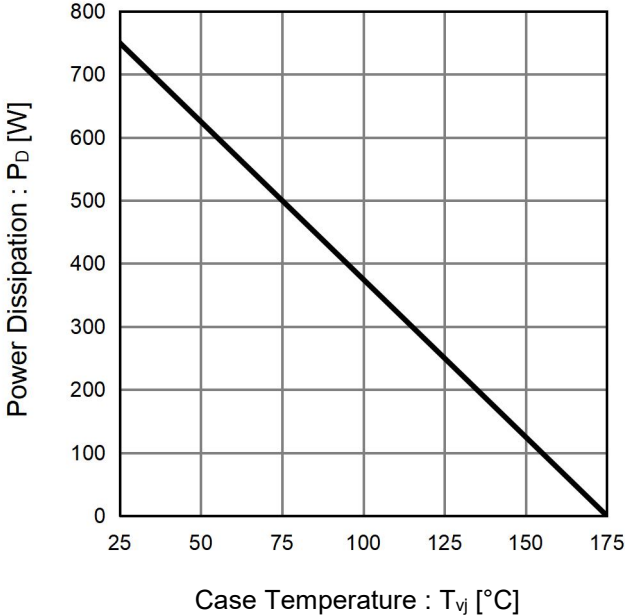


Fig.2 Maximum Safe Operating Area

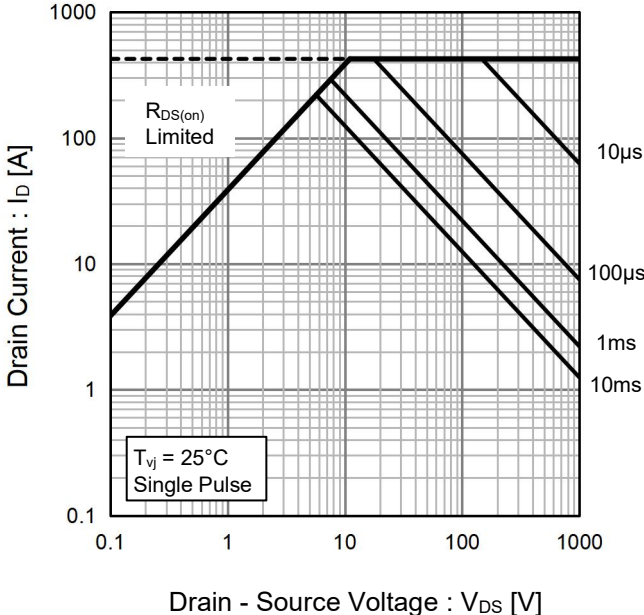


Fig.3 Typical Transient Thermal Impedance vs. Pulse Width

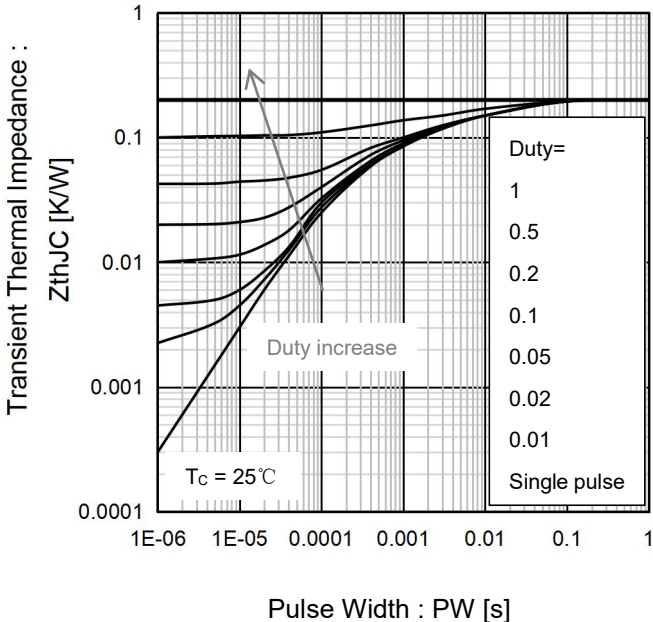


Fig.4 $T_{vj} = 25^{\circ}\text{C}$ Typical Output Characteristics

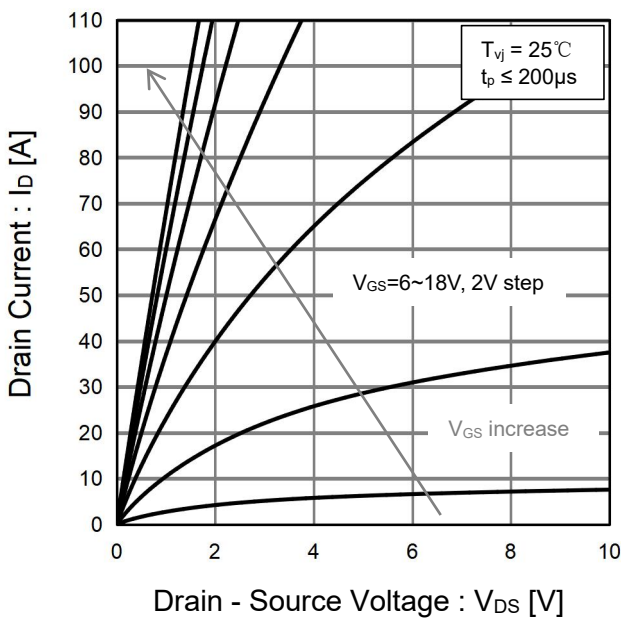


Fig.5 $T_{vj} = 25^{\circ}\text{C}$ 3rd Quadrant Characteristics

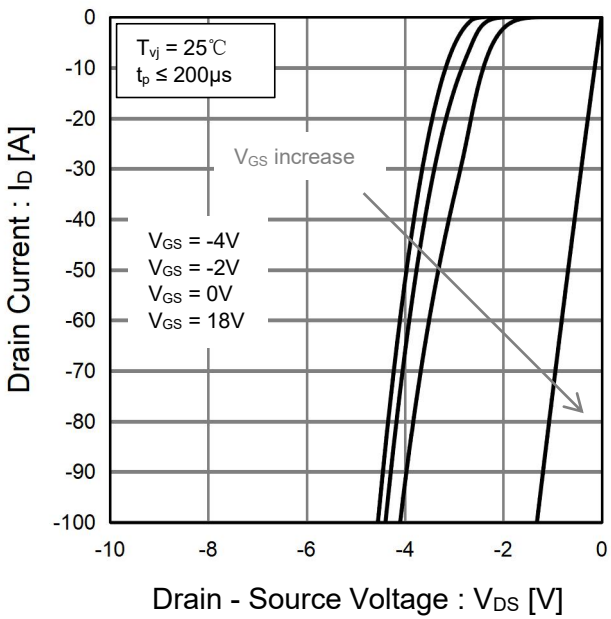


Fig.6 $T_{vj} = 175^{\circ}\text{C}$ Typical Output Characteristics

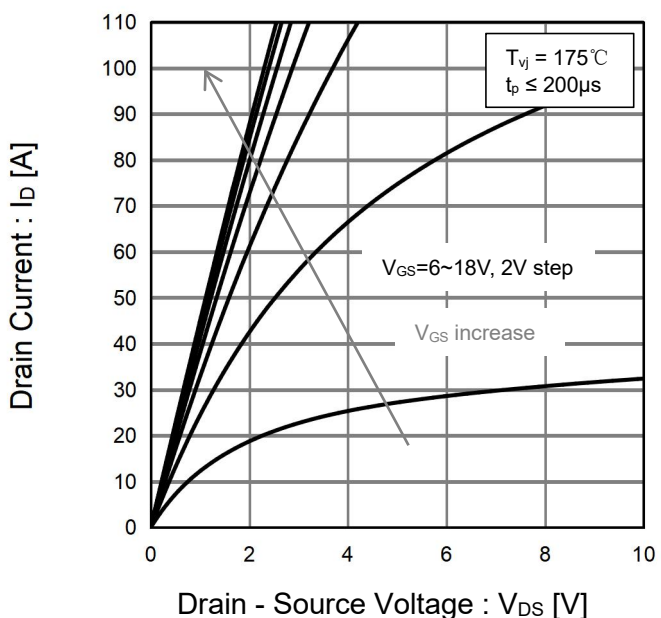


Fig.7 $T_{vj} = 175^{\circ}\text{C}$ 3rd Quadrant Characteristics

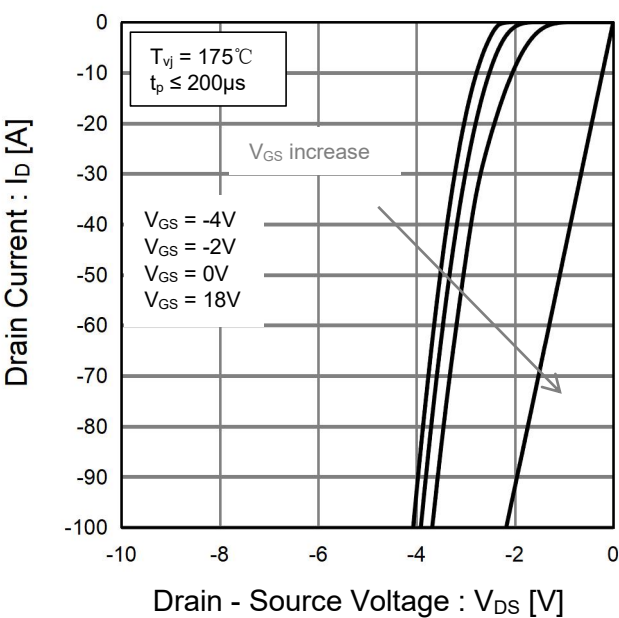


Fig.8 Typical Transfer Characteristics

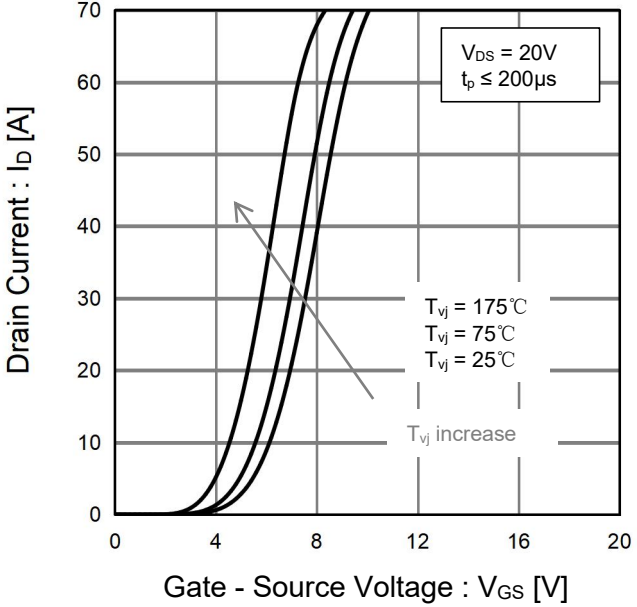


Fig.9 Static Drain - Source On - State Resistance vs. Gate - Source Voltage

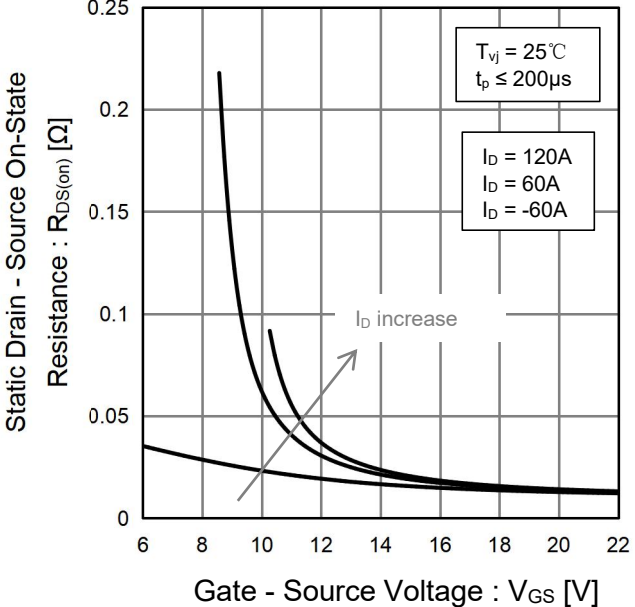


Fig.10 Static Drain - Source On - State Resistance vs. Drain Current

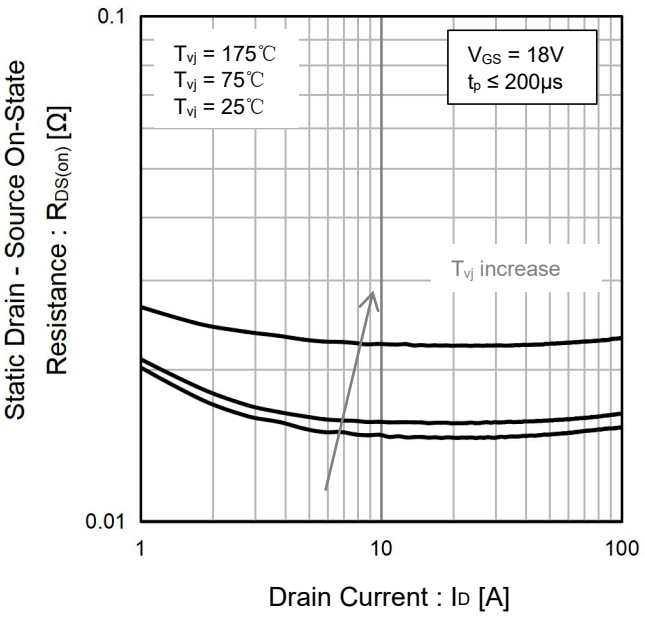


Fig.11 Static Drain - Source On - State Resistance vs. Virtual Junction Temperature

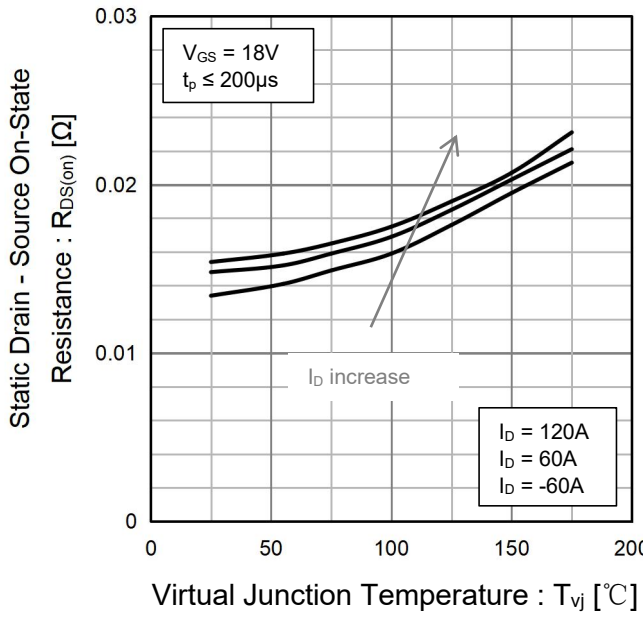


Fig.12 Body Diode Forward Voltage vs. Gate - Source Voltage

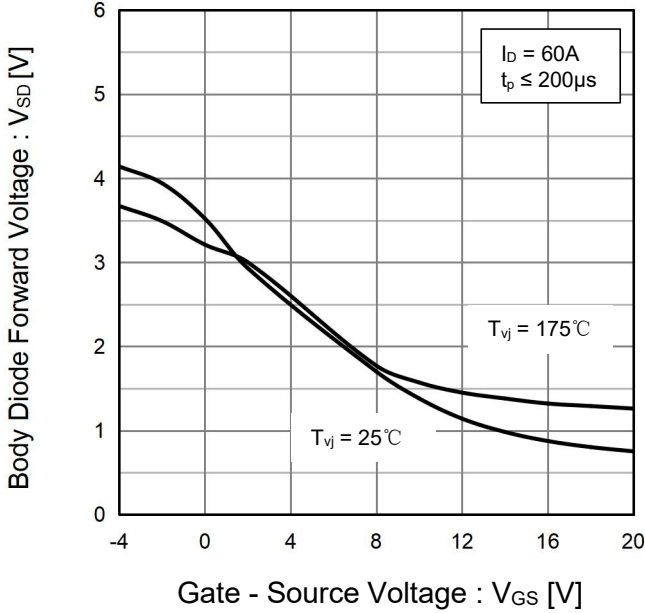


Fig.13 Gate Threshold Voltage vs. Virtual Junction Temperature

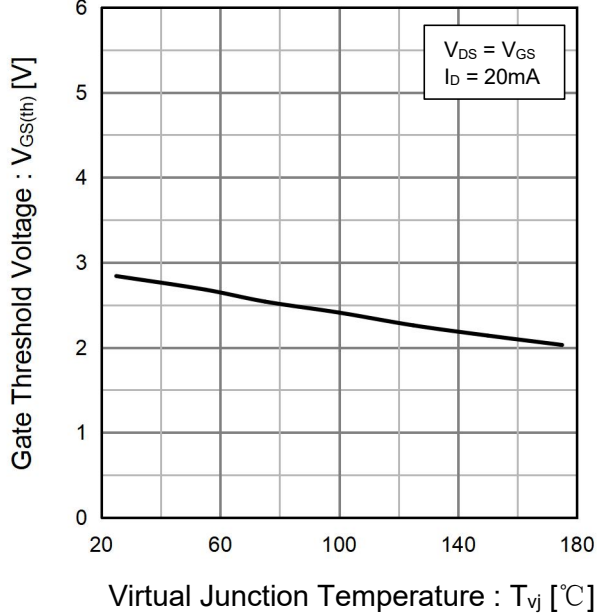


Fig.14 Typical Capacitance vs. Drain - Source Voltage

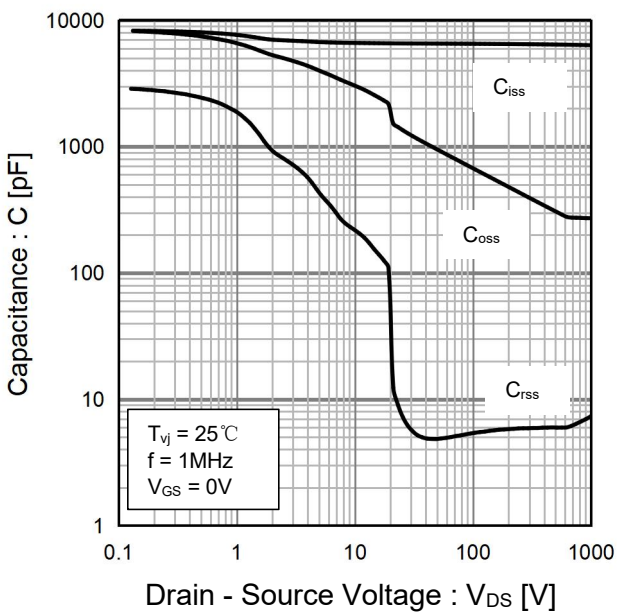


Fig.15 Coss Stored Energy

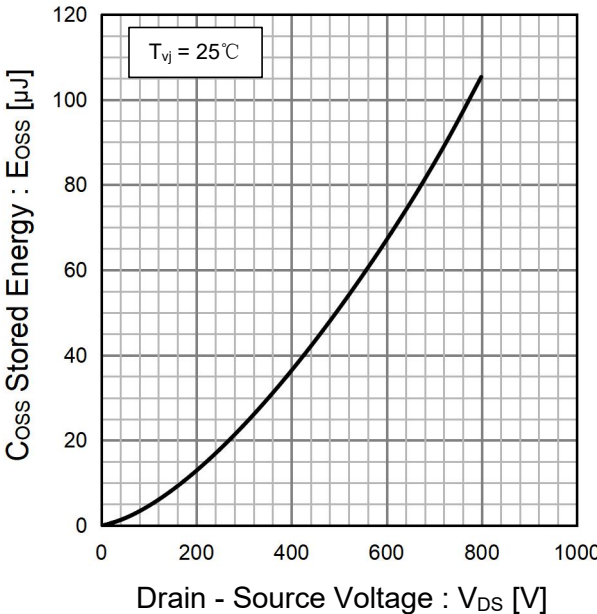


Fig.16 Dynamic Input Characteristics

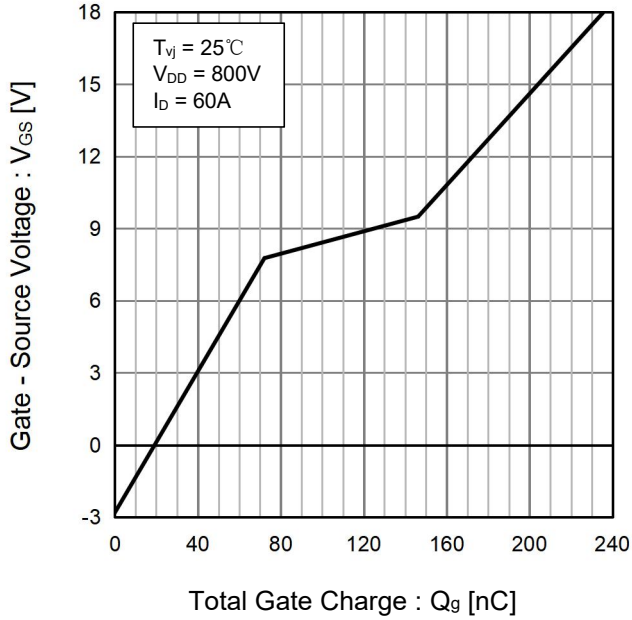


Fig.17 Typical Switching Time vs. External Gate Resistance

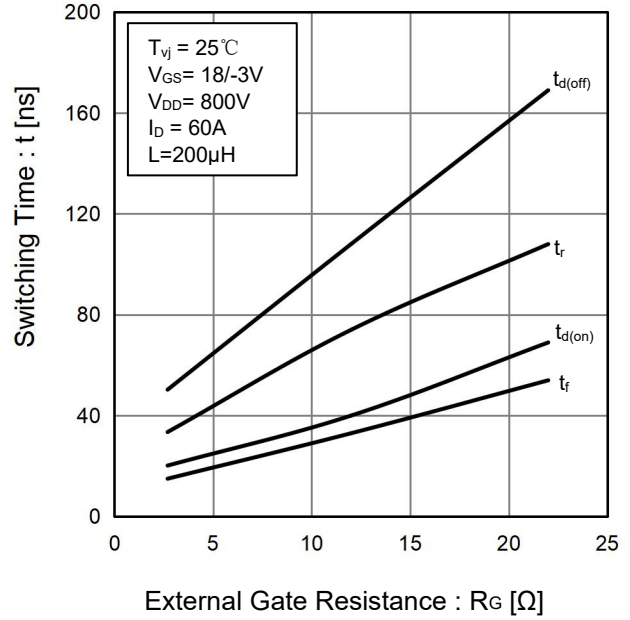


Fig.18 Typical Switching Energy vs. External Gate Resistance

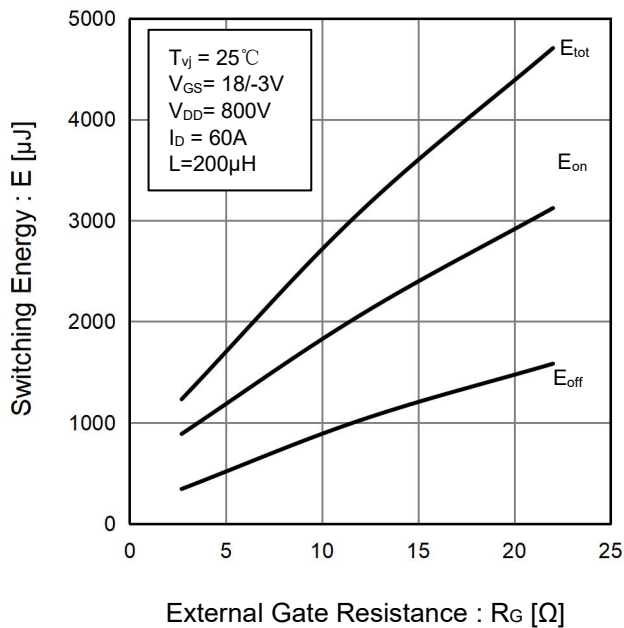


Fig.19 Typical Switching Energy vs. Drain Current

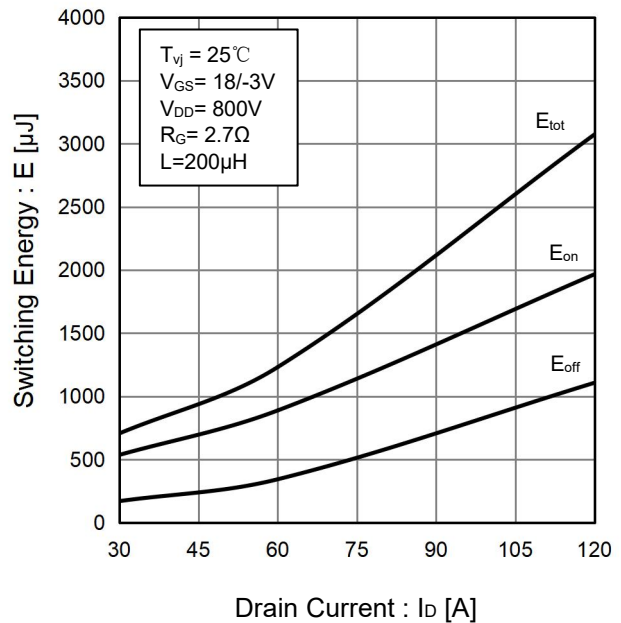
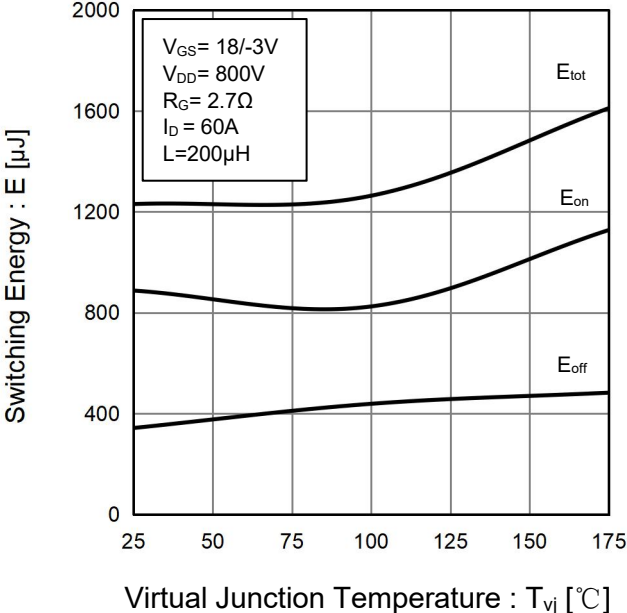
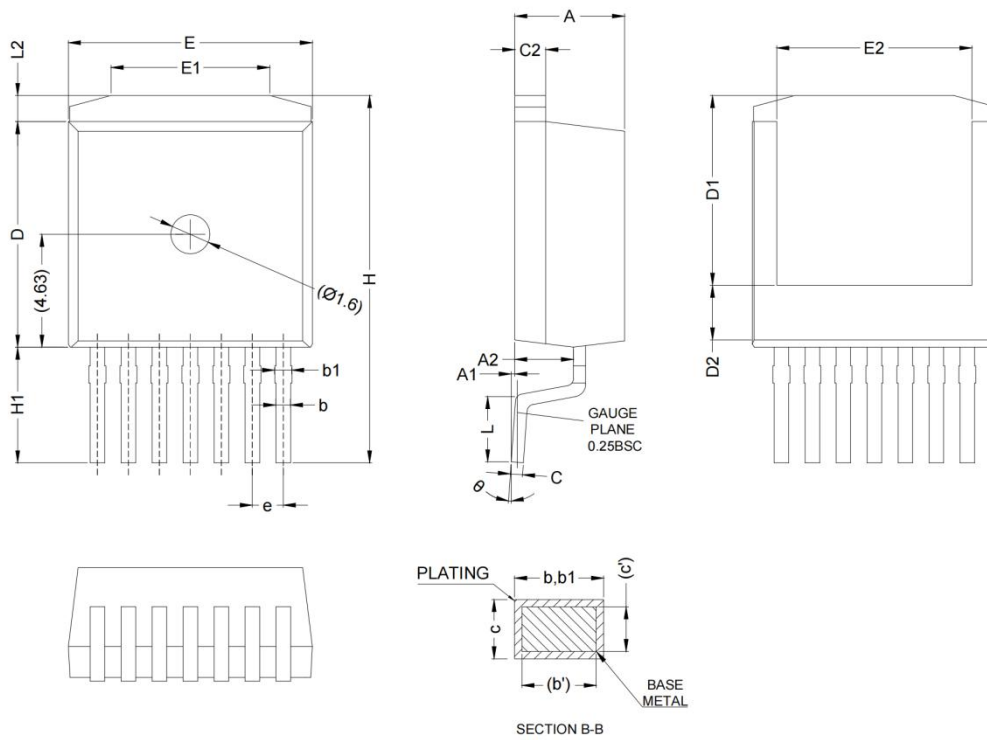


Fig.20 Typical Switching Energy vs. Virtual Junction Temperature



TO263-7L Package Information



Items	Min	Max
A	4.30	4.70
A1	-	0.25
A2	2.20	2.60
b	0.52	0.72
b'	0.50	0.70
b1	0.60	0.80
c	0.42	0.62
c'	0.40	0.60
c2	1.07	1.47
D	9.05	9.45
D1	7.58	7.98
D2	2.05	2.45
e	1.27 BSC	
E	9.80	10.20
E1	6.30	6.70
E2	7.80	8.20
L	2.48	2.88
L2	0.87	1.27
H	14.87	15.27
H1	4.55	4.95
θ	0°	8°

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